

Notice of References Cited

Application/Control No.

10/786,343

Applicant(s)/Patent Under
Reexamination
NASH, MICHAEL TEPOE

Examiner

Christina Russell

Art Unit

2837

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,408,914	04-1995	Breitweiser et al.	84/477R
*	B	US-2003/0110926	06-2003	Sitrick et al.	84/477.00R
*	C	US-5,837,912	11-1998	Eagen, Chris S.	84/267
*	D	US-6,191,348	02-2001	Johnson, Steven T.	84/485R
*	E	US-5,837,912	11-1998	Eagen, Chris S.	84/267
*	F	US-6,191,350	02-2001	Okulov et al.	84/646
*	G	US-5,442,986	08-1995	Cota, Jose G.	84/267
*	H	US-6,291,755	09-2001	Hine et al.	84/454
*	I	US-6,350,942	02-2002	Thomson, Richard Atwater	84/477R
*	J	US-4,080,867	03-1978	Ratanangsu, Srinkarn	84/477R
*	K	US-4,919,031	04-1990	Matsumoto, Naoaki	84/601
*	L	US-6,888,057	05-2005	Juszkiewicz et al.	84/645
*	M	US-6,253,654	07-2001	Mercurio, Peter G	84/267

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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	U	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,452,081	09-2002	Ravagni et al.	84/477R
*	B	US-6,645,067	11-2003	Okita et al.	463/7
*	C	US-6,653,543	11-2003	Kulas, Charles J.	84/454
*	D	US-6,995,310	02-2006	Knapp et al.	84/722
*	E	US-5,038,662	08-1991	Ho, Tracy K.	84/723
*	F	US-6,162,981	12-2000	Newcomer et al.	84/485R
*	G	US-5,977,467	11-1999	Freeland et al.	84/454
*	H	US-4,378,720	04-1983	Nakada et al.	84/611
*	I	US-5,270,475	12-1993	Weiss et al.	84/603
*	J	US-5,266,735	11-1993	Shaffer et al.	84/609
*	K	US-5,040,447	08-1991	Murata et al.	84/612
*	L	US-4,791,848	12-1988	Blum, Jr., Kenneth L.	84/453
*	M	US-4,318,327	03-1982	Toups, Daniel J.	84/477R

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,889,221	03-1999	Dejima, Tatsuya	84/291
*	B	US-2005/0252359	11-2005	Cook, Randy Mitchell	084/464.00A
*	C	US-6,787,690	09-2004	Celi et al.	84/723
*	D	US-6,065,765	05-2000	Chang, Richard M.	280/288.3
*	E	US-4,658,690	04-1987	Aitken et al.	84/629
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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